

# Device Modeling Report

COMPONENTS : VOLTAGE COMPARATOR  
PART NUMBER : LM311M  
MANUFACTURER : NATIONAL



**Bee Technologies Inc.**

## BJT MODEL

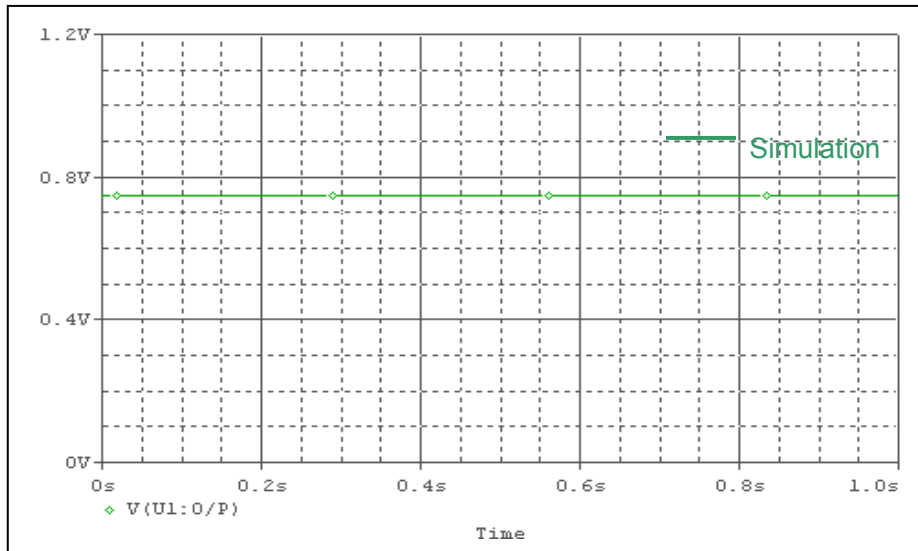
| Pspice model parameter | Model description                             |
|------------------------|-----------------------------------------------|
| IS                     | Saturation Current                            |
| BF                     | Ideal Maximum Forward Beta                    |
| CJC                    | Zero-bias Collector-Base Junction Capacitance |
| TF                     | Forward Transit Time                          |
| TR                     | Reverse Transit Time                          |

## DIODE MODEL

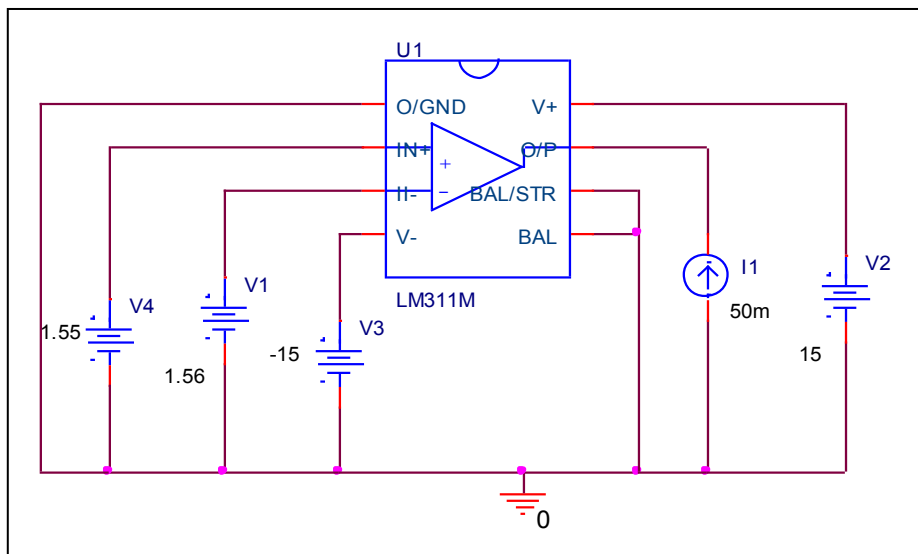
| Pspice model parameter | Model description  |
|------------------------|--------------------|
| IS                     | Saturation Current |
| RS                     | Series Resistance  |

## Output Low Voltage

### Simulation result



### Evaluation Circuit

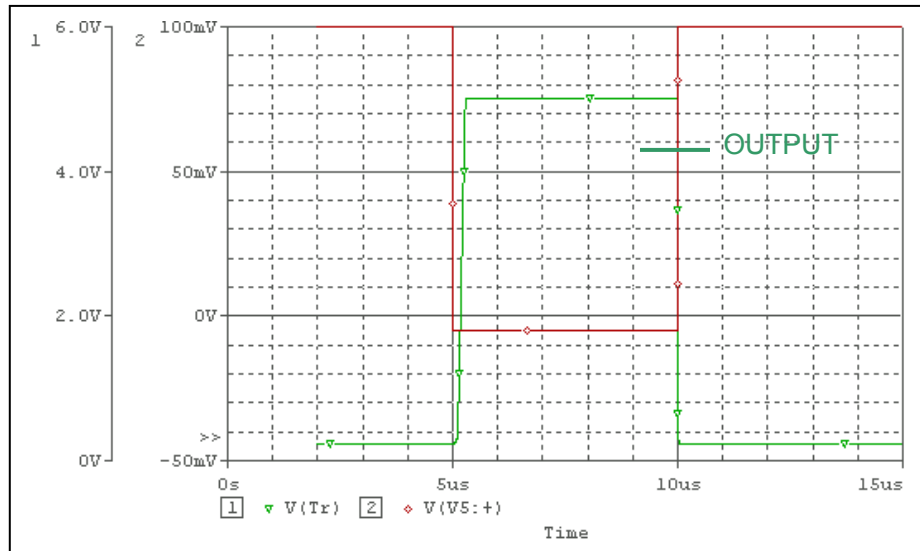


### Compasion Table

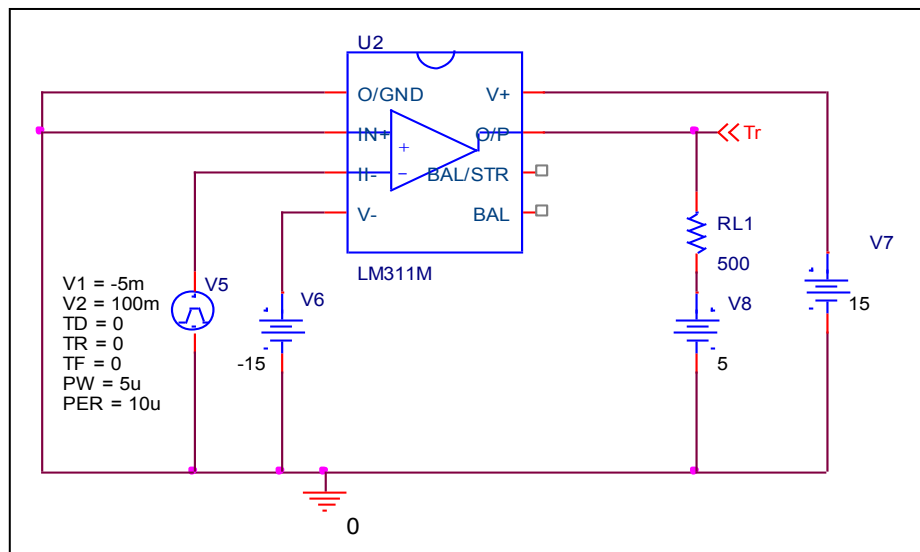
| $I_o = 50\text{mA}$  | Measurement | Simulation | %Error |
|----------------------|-------------|------------|--------|
| $V_{ol} \text{ (V)}$ | 0.75        | 0.749735   | -0.035 |

## Response time (Rise time and Transition time)

### Simulation result



### Evaluation Circuit

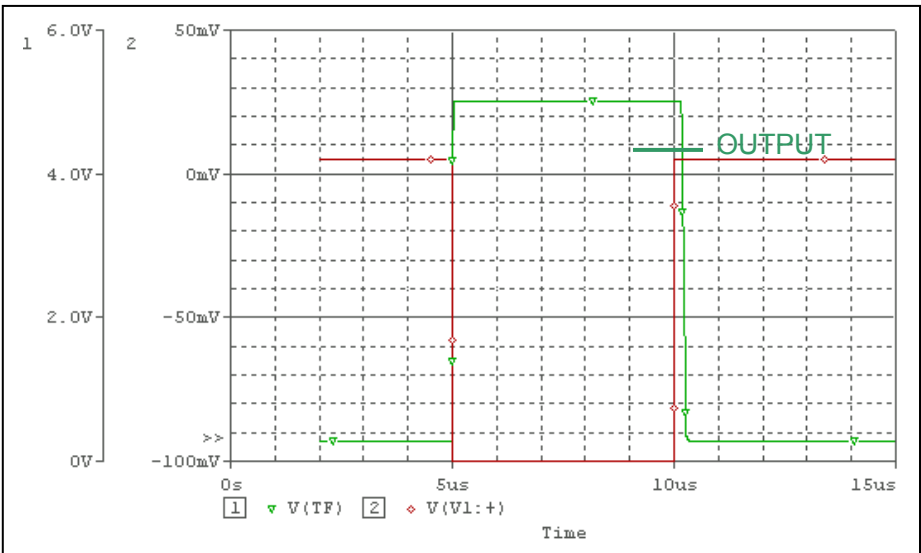


### Compasion Table

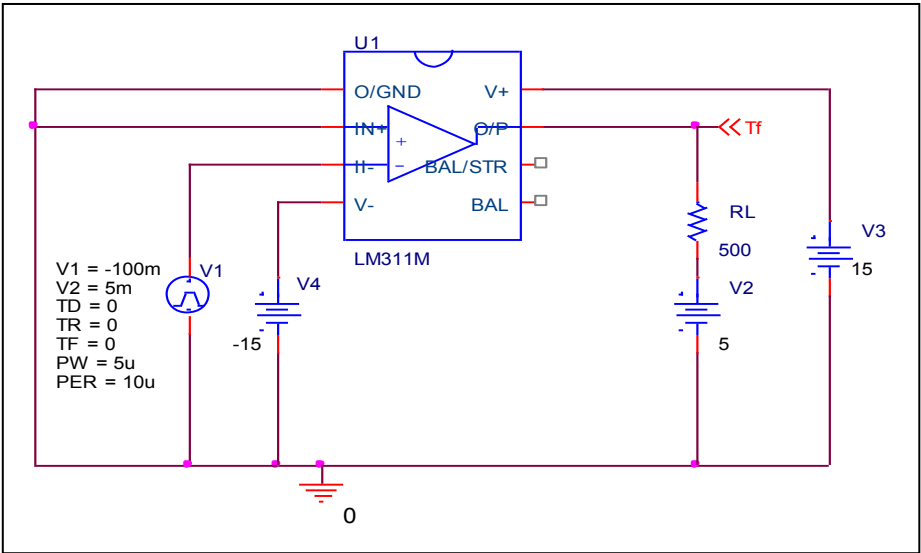
|                               | Measurement | Simulation | % Error |
|-------------------------------|-------------|------------|---------|
| <b>Rising delay time (us)</b> | 0.125       | 0.124079   | -0.737  |
| <b>Transition time (us)</b>   | 0.140       | 0.13897    | -0.736  |

# Response time (Falling time)

## Simulation result



## Evaluation Circuit

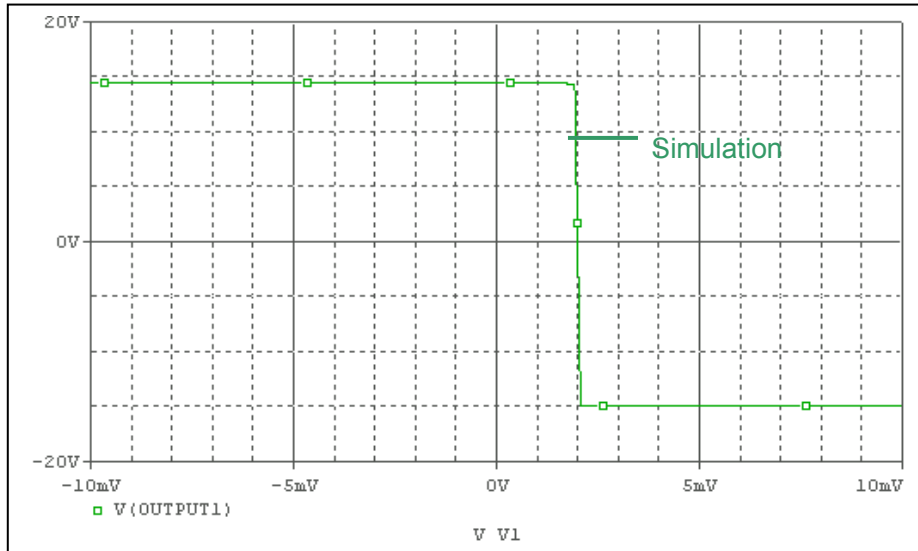


## Compasion Table

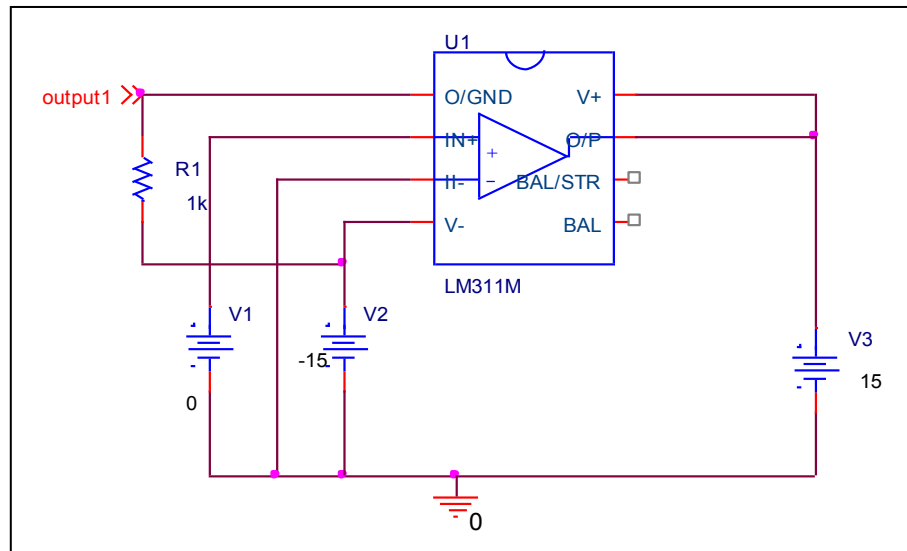
|                         | Measurement | Simulation | % Error |
|-------------------------|-------------|------------|---------|
| Falling delay time (us) | 0.175       | 0.174974   | -0.015  |

## Input Offset Voltage Characteristics

### Simulation result



### Evaluation Circuit

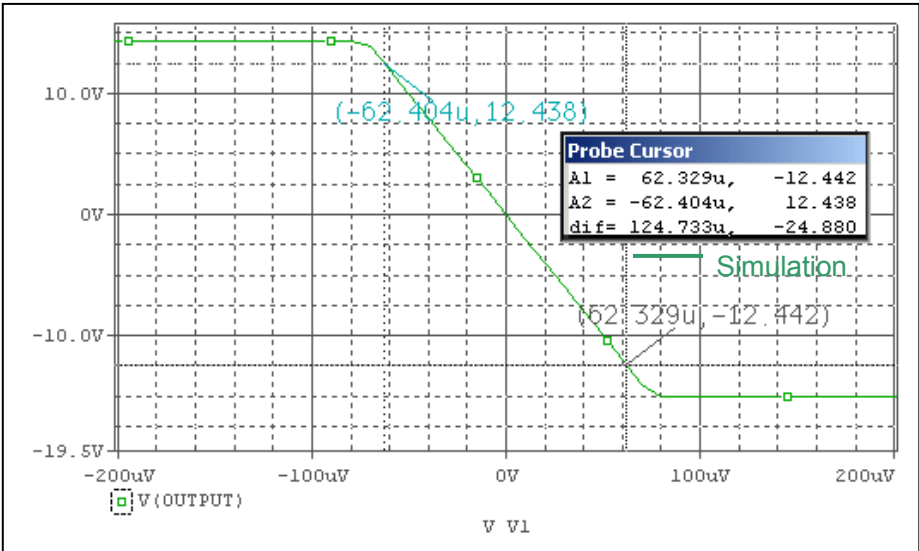


### Compasion Table

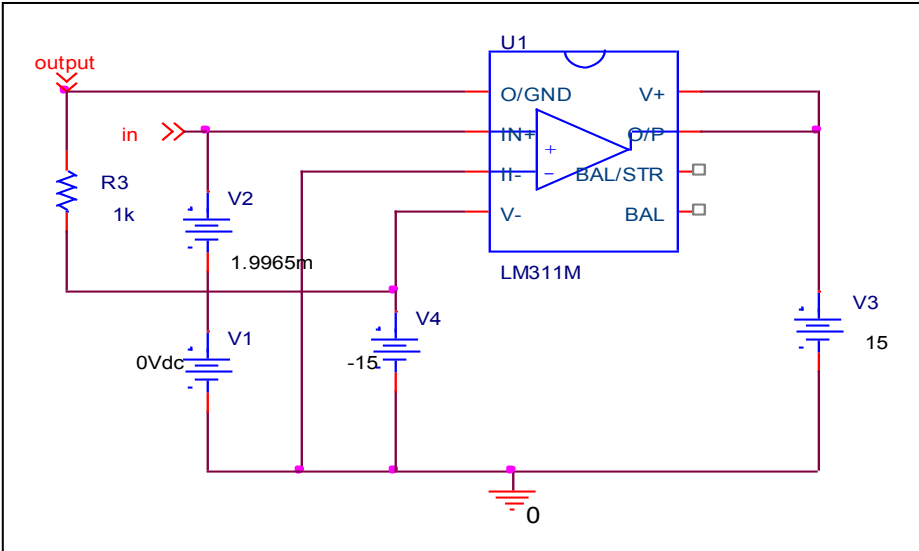
|              | Measurement | Simulation | %Error |
|--------------|-------------|------------|--------|
| $V_{io}(mV)$ | 2           | 1.9965     | -0.175 |

# Av Characteristics

## Simulation result



## Evaluation Circuit



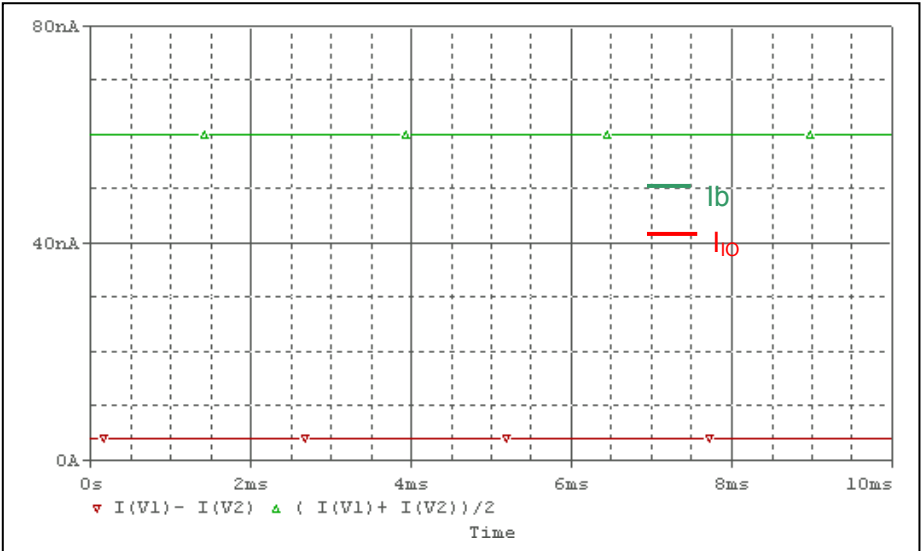
$$A_v = 24.880 / 124.733u$$

## Compasion Table

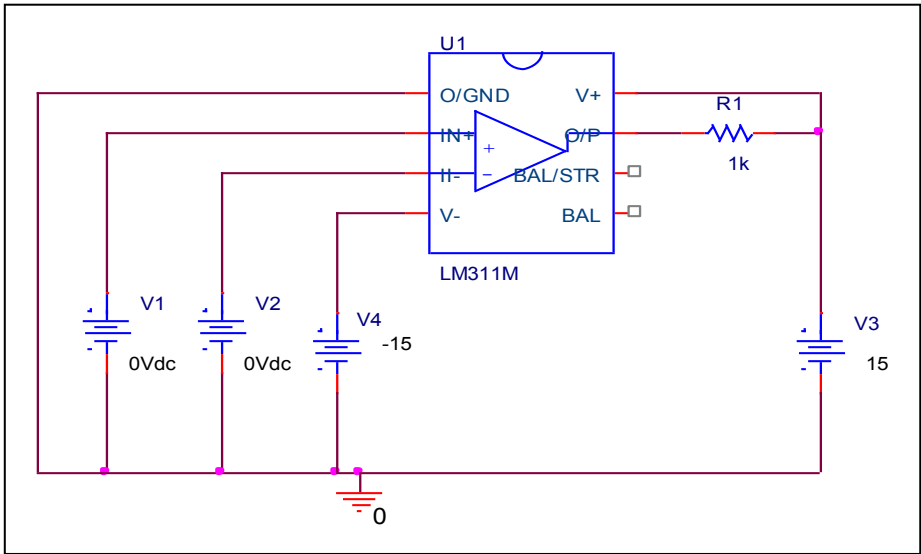
| $R_L = 1k\Omega$ | Measurement | Simulation | %Error |
|------------------|-------------|------------|--------|
| $A_v$ (V/mV)     | 200         | 199.466    | -0.267 |

# Input Bias Current Characteristics

## Simulation result



## Evaluation Circuit



## Compasion Table

|                      | Measurement | Simulation | % Error |
|----------------------|-------------|------------|---------|
| I <sub>b</sub> (nA)  | 100         | 100.059    | 0.059   |
| I <sub>io</sub> (nA) | 6           | 6.0075     | 0.125   |